

NXH160T120L2Q1PG, NXH160T120L2Q1SG

Q1PACK Module

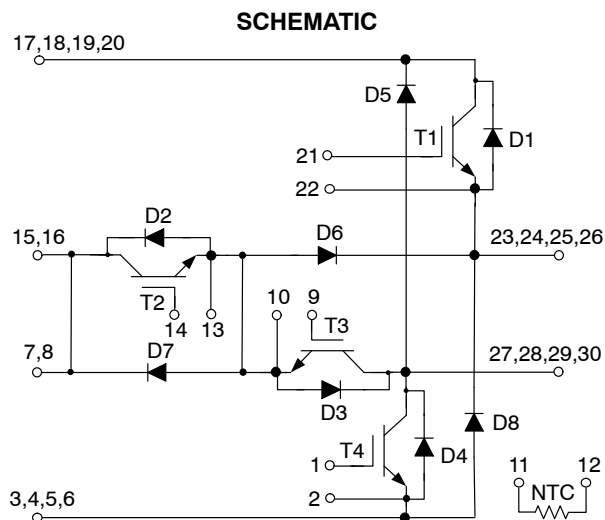
This high-density, integrated power module combines high-performance IGBTs with rugged anti-parallel diodes.

Features

- Extremely Efficient Trench with Fieldstop Technology
- Low Switching Loss Reduces System Power Dissipation
- Module Design Offers High Power Density
- Low Inductive Layout
- Q1PACK Package with Press-Fit and Solder Pins

Typical Applications

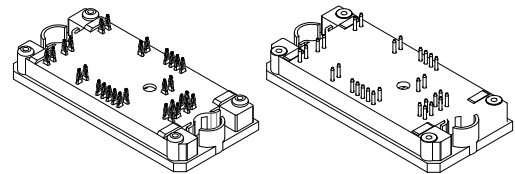
- Solar Inverters
- Uninterruptable Power Supplies



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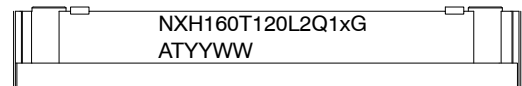
PACKAGE PICTURE



**Q1PACK
CASE 180AD
PRESS FIT**

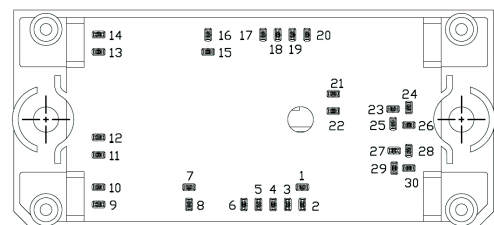
**Q1PACK
CASE 180AQ
SOLDER PINS**

DEVICE MARKING



x = P or S
G = Pb-Free Package
AT = Assembly & Test Site Code
YYWW = Year and Work Week Code

PIN ASSIGNMENTS



ORDERING INFORMATION

See detailed ordering and shipping information on page 14 of this data sheet.

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Table 1. ABSOLUTE MAXIMUM RATINGS

Rating	Symbol	Value	Unit
HALFBRIDGE IGBT INVERSE DIODE (D1, D4)			
Peak Repetitive Reverse Voltage	V_{RRM}	1200	V
Forward Current, DC @ $T_h = 80^\circ\text{C}$	I_F	20	A
Repetitive Peak Forward Current T_{pulse} limited by $T_{J\text{max}}$	I_{FRM}	80	A
Power Dissipation per Diode $T_j = T_{J\text{max}}$ $T_h = 80^\circ\text{C}$	P_{tot}	51	W
Maximum Junction Temperature	T_J	150	$^\circ\text{C}$
HALFBRIDGE IGBT (T1, T4)			
Collector-emitter voltage	V_{CES}	1200	V
Collector current @ $T_h = 80^\circ\text{C}$	I_C	140	A
Pulsed Collector Current, T_{pulse} Limited by $T_{J\text{max}}$	I_{CM}	480	A
Power Dissipation per IGBT $T_j = T_{J\text{max}}$ $T_h = 80^\circ\text{C}$	P_{tot}	280	W
Gate-emitter voltage	V_{GE}	± 20	V
Short Circuit Withstand Time $V_{GE} = 15\text{ V}$, $V_{CE} = 600\text{ V}$, $T_J \leq 150^\circ\text{C}$	T_{SC}	10	μs
Maximum Junction Temperature	T_J	150	$^\circ\text{C}$
NP DIODE (D6, D7)			
Peak Repetitive Reverse Voltage	V_{RRM}	650	V
Forward Current, DC @ $T_h = 80^\circ\text{C}$	I_F	58	A
Repetitive Peak Forward Current, T_{pulse} limited by $T_{J\text{max}}$	I_{FRM}	200	A
Power Dissipation Per Diode $T_j = T_{J\text{max}}$ $T_h = 80^\circ\text{C}$	P_{tot}	89	W
Maximum Junction Temperature	T_J	150	$^\circ\text{C}$
NP IGBT (T2, T3)			
Collector-emitter voltage	V_{CES}	650	V
Collector current @ $T_h = 80^\circ\text{C}$	I_C	83	A
Pulsed collector current, T_{pulse} limited by $T_{J\text{max}}$	I_{CM}	235	A
Power Dissipation Per IGBT $T_j = T_{J\text{max}}$ $T_h = 80^\circ\text{C}$	P_{tot}	117	W
Gate-emitter voltage	V_{GE}	± 20	V
Short Circuit Withstand Time $V_{GE} = 15\text{ V}$, $V_{CE} = 400\text{ V}$, $T_J \leq 150^\circ\text{C}$	T_{sc}	5	μs
Maximum Junction Temperature	T_J	150	$^\circ\text{C}$
NP INVERSE DIODE (D2, D3)			
Peak Repetitive Reverse Voltage	V_{RRM}	650	V
Forward Current, DC @ $T_h = 80^\circ\text{C}$	I_F	17	A
Repetitive Peak Forward Current, T_{pulse} limited by $T_{J\text{max}}$	I_{FRM}	68	A
Power Dissipation Per Diode $T_j = T_{J\text{max}}$ $T_h = 80^\circ\text{C}$	P_{tot}	28	W
Maximum Junction Temperature	T_J	150	$^\circ\text{C}$
HALFBRIDGE DIODE (D5, D8)			
Peak Repetitive Reverse Voltage	V_{RRM}	1200	V
Forward Current, DC @ $T_h = 80^\circ\text{C}$ (per diode)	I_F	45	A
Repetitive Peak Forward Current, T_{pulse} limited by $T_{J\text{max}}$	I_{FRM}	180	A
Power Dissipation Per Diode $T_j = T_{J\text{max}}$ $T_h = 80^\circ\text{C}$	P_{tot}	78	W

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Table 1. ABSOLUTE MAXIMUM RATINGS

Rating	Symbol	Value	Unit
HALFBRIDGE DIODE (D5, D8)			
Junction Temperature	T_J	150	°C
THERMAL PROPERTIES			
Operating Temperature under switching condition	$T_{VJ\text{ OP}}$	-40 to $(T_{j\text{ max}}-25)$	°C
Storage Temperature range	T_{stg}	-40 to 125	°C
INSULATION PROPERTIES			
Isolation test voltage, $t = 1$ sec, 60 Hz/50 Hz	V_{is}	3000	V_{RMS}
Creepage distance		12.7	mm
Clearance		8.06	mm

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

Table 2. ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Test Conditions	Symbol	Min	Typ	Max	Unit
HALFBRIDGE IGBT INVERSE DIODE (D1, D4) CHARACTERISTICS						
Forward voltage	$I_F = 7\text{ A}$, $T_J = 25^\circ\text{C}$ $I_F = 7\text{ A}$, $T_J = 125^\circ\text{C}$	V_F	— —	1.46 1.49	2.7 —	V
Thermal Resistance – chip-to-heatsink	Thermal grease, Thickness = 2 Mil $\pm$ 2%, $\lambda = 1\text{ W/mK}$	R_{thJH}		1.864		°C/W
HALFBRIDGE IGBT (T1, T4) CHARACTERISTICS						
Collector-emitter saturation voltage	$V_{GE} = 15\text{ V}$, $I_C = 160\text{ A}$, $T_J = 25^\circ\text{C}$ $V_{GE} = 15\text{ V}$, $I_C = 160\text{ A}$, $T_J = 125^\circ\text{C}$	$V_{CE(\text{sat})}$	— —	2.06 2.10	2.50 —	V
Gate-emitter threshold voltage	$V_{GE} = V_{CE}$, $I_C = 6\text{ mA}$	$V_{GE(\text{TH})}$	5.0	5.80	6.50	V
Collector-emitter cutoff current	$V_{GE} = 0\text{ V}$, $V_{CE} = 1200\text{ V}$	I_{CES}	—	—	800	μA
Gate leakage current	$V_{GE} = 20\text{ V}$, $V_{CE} = 0\text{ V}$	I_{GES}	—	—	800	nA
Turn-on delay time	$T_J = 125^\circ\text{C}$ $V_{CE} = 350\text{ V}$, $I_C = 100\text{ A}$ $V_{GE} = \pm 15\text{ V}$, $R_G = 4\ \Omega$	$t_{d(\text{on})}$	—	55	—	ns
Rise time		t_r	—	50	—	
Turn-off delay time		$t_{d(\text{off})}$	—	430	—	
Fall time		t_f	—	105	—	
Turn on switching loss		E_{on}	—	2.73	—	mJ
Turn off switching loss		E_{off}	—	3.58	—	
Input capacitance	$V_{CE} = 25\text{ V}$, $V_{GE} = 0\text{ V}$, $f = 10\text{ kHz}$	C_{ies}	—	38164	—	pF
Output capacitance		C_{oes}	—	644	—	
Reverse transfer capacitance		C_{res}	—	784	—	
Gate charge total	$V_{CE} = 600\text{ V}$, $I_C = 160\text{ A}$, $V_{GE} = 15\text{ V}$	Q_g	—	1664	—	nC
Thermal Resistance – chip-to-heatsink	Thermal grease, Thickness = 2 Mil $\pm$ 2%, $\lambda = 1\text{ W/mK}$	R_{thJH}		0.337		°C/W
NP DIODE (D6, D7) CHARACTERISTICS						
Forward voltage	$V_{GE} = 0\text{ V}$, $I_F = 150\text{ A}$, $T_J = 25^\circ\text{C}$ $V_{GE} = 0\text{ V}$, $I_F = 150\text{ A}$, $T_J = 125^\circ\text{C}$	V_F	— —	2.15 2.36	2.60 —	V
Reverse leakage current	$V_{CE} = 650\text{ V}$, $V_{GE} = 0\text{ V}$	I_r	—	—	200	μA
Reverse recovery time	$T_J = 125^\circ\text{C}$ $V_{CE} = 350\text{ V}$, $I_C = 100\text{ A}$ $V_{GE} = \pm 15\text{ V}$, $R_G = 4\ \Omega$	t_{rr}	—	225	—	ns
Reverse recovery charge		Q_{rr}	—	6.15	—	μC
Peak reverse recovery current		I_{rrm}	—	85	—	A
Peak rate of fall of recovery current		di/dt_{max}	—	1315	—	A/ μs
Reverse recovery energy		E_{rr}	—	1.336	—	mJ
Thermal Resistance – chip-to-heatsink	Thermal grease, Thickness = 2 Mil $\pm$ 2%, $\lambda = 1\text{ W/mK}$	R_{thJH}	—	1.07	—	°C/W

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Table 2. ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Test Conditions	Symbol	Min	Typ	Max	Unit
NP IGBT (T2, T3)						
Collector-emitter saturation voltage	$V_{CE} = 15\text{ V}, I_C = 150\text{ A}, T_J = 25^\circ\text{C}$ $V_{CE} = 15\text{ V}, I_C = 150\text{ A}, T_J = 125^\circ\text{C}$	$V_{CE(sat)}$	— —	1.65 1.84	2.0 —	V
Gate-emitter threshold voltage	$V_{GE} = V_{CE}, I_C = 8\text{ mA}$	$V_{GE(TH)}$	5.0	6.10	6.90	V
Collector-emitter cutoff current	$V_{GE} = 0\text{ V}, V_{CE} = 650\text{ V}$	I_{CES}	—	—	400	μA
Gate leakage current	$V_{GE} = 20\text{ V}, V_{CE} = 0\text{ V}$	I_{GES}	—	—	800	nA
Turn-on delay time	$T_J = 125^\circ\text{C}$ $V_{CE} = 350\text{ V}, I_C = 100\text{ A}$ $V_{GE} = \pm 15\text{ V}, R_G = 4\ \Omega$	$t_{d(on)}$	—	46	—	ns
Rise time		t_r	—	48	—	
Turn-off delay time		$t_{d(off)}$	—	250	—	
Fall time		t_f	—	105	—	
Turn on switching loss		E_{on}	—	1.245	—	mJ
Turn off switching loss		E_{off}	—	2.525	—	
Input capacitance	$V_{CE} = 25\text{ V}, V_{GE} = 0\text{ V}, f = 10\text{ kHz}$	C_{ies}	—	19380	—	pF
Output capacitance		C_{oes}	—	570	—	
Reverse transfer capacitance		C_{res}	—	496	—	
Gate charge total	$V_{CE} = 480\text{ V}, I_C = 150\text{ A}, V_{GE} = 15\text{ V}$	Q_g	—	790	—	nC
Thermal Resistance – chip-to-heatsink	Thermal grease, Thickness = 2 Mil $\pm$ 2%, $\lambda = 1\text{ W/mK}$	R_{thJH}	—	0.81	—	$^\circ\text{C/W}$

NP INVERSE DIODE (D2, D3)

Forward voltage	$V_{GE} = 0\text{ V}, I_F = 15\text{ A}, T_J = 25^\circ\text{C}$ $V_{GE} = 0\text{ V}, I_F = 15\text{ A}, T_J = 125^\circ\text{C}$	V_F	— —	1.60 1.59	2.20 —	V
Thermal Resistance – chip-to-heatsink	Thermal grease, Thickness = 2 Mil $\pm$ 2%, $\lambda = 1\text{ W/mK}$	R_{thJH}		3.43		$^\circ\text{C/W}$

HALFBRIDGE DIODE (D5, D8)

Forward voltage	$V_{GE} = 0\text{ V}, I_F = 150\text{ A}, T_J = 25^\circ\text{C}$ $V_{GE} = 0\text{ V}, I_F = 150\text{ A}, T_J = 125^\circ\text{C}$	V_F	— —	2.50 2.80	3.50 —	V
Reverse leakage current	$V_{CE} = 1200\text{ V}, V_{GE} = 0\text{ V}$	I_r	—	—	200	μA
Reverse recovery time	$T_J = 125^\circ\text{C}$ $V_{CE} = 350\text{ V}, I_C = 100\text{ A}$ $V_{GE} = \pm 15\text{ V}, R_G = 4\ \Omega$	t_{rr}	—	405	—	ns
Reverse recovery charge		Q_{rr}	—	15.5	—	μC
Peak reverse recovery current		I_{rrm}	—	220	—	A
Peak rate of fall of recovery current		di/dt_{max}	—	5440	—	A/ μs
Reverse recovery energy		E_{rr}	—	5.225	—	mJ
Thermal Resistance – chip-to-heatsink	Thermal grease, Thickness = 2 Mil $\pm$ 2%, $\lambda = 1\text{ W/mK}$	R_{thJH}	—	1.213	—	$^\circ\text{C/W}$

THERMISTOR CHARACTERISTICS

Nominal resistance		R_{25}	—	22	—	k Ω
Nominal resistance	$T = 100^\circ\text{C}$	R_{100}	—	1486	—	Ω
Deviation of R25		DR/R	-5	—	5	%
Power dissipation		P_D	—	200	—	mW
Power dissipation constant			—	2	—	mW/K
B-value	B(25/50), tol $\pm$ 3%		—	3950	—	K
B-value	B(25/100), tol $\pm$ 3%		—	3998	—	K

TYPICAL CHARACTERISTICS – HALF BRIDGE IGBT AND NEUTRAL POINT FORWARD DIODE

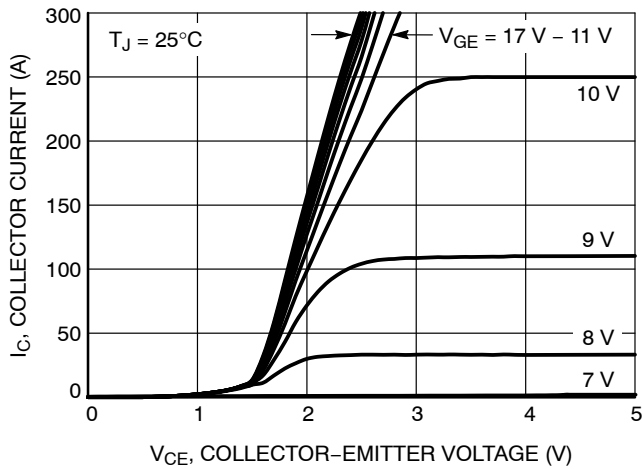


Figure 1. Typical Output Characteristics

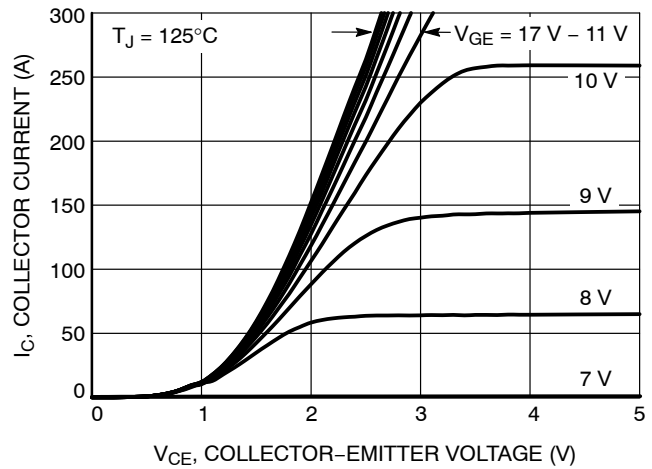


Figure 2. Typical Output Characteristics

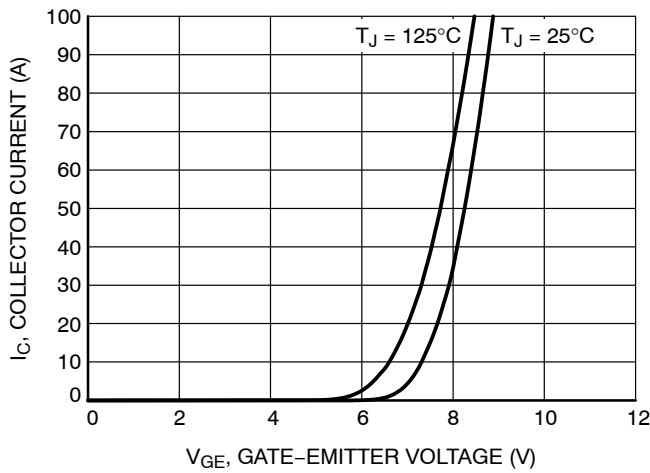


Figure 3. Typical Transfer Characteristics

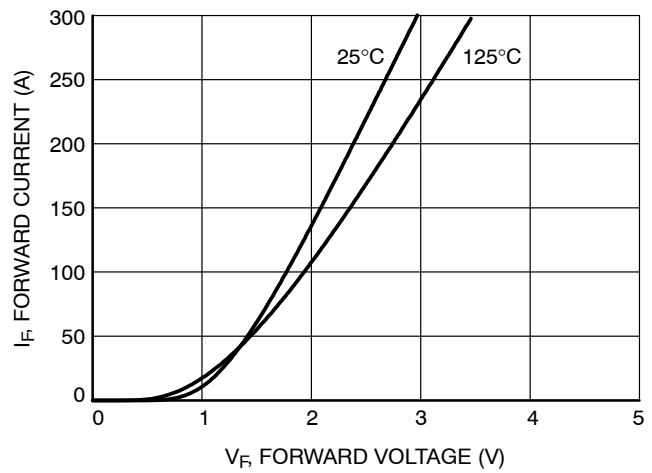


Figure 4. Diode Forward Characteristics

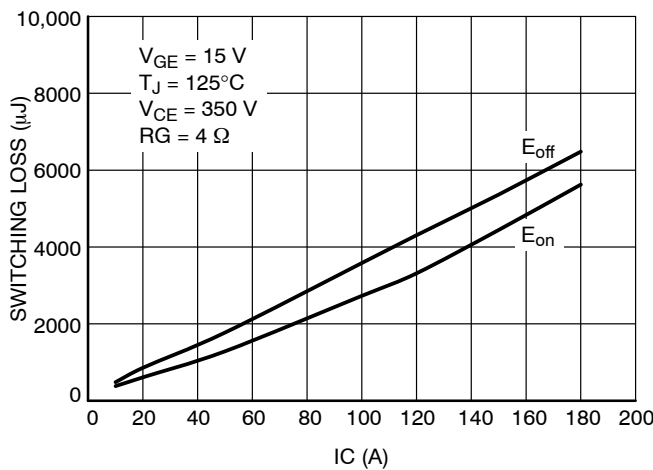


Figure 5. Typical Switching Loss vs. IC

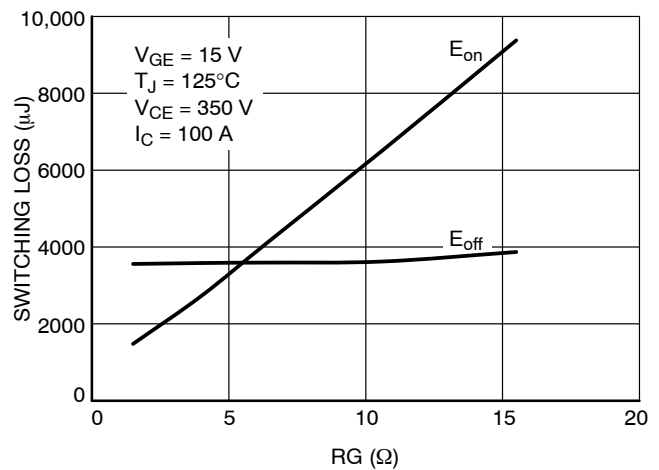


Figure 6. Typical Switching Loss vs. RG

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TYPICAL CHARACTERISTICS – HALF BRIDGE IGBT AND NEUTRAL POINT FORWARD DIODE

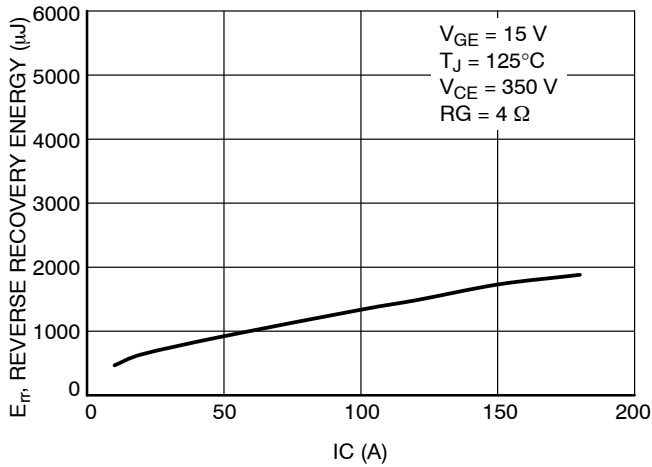


Figure 7. Typical Reverse Recovery Energy Loss vs. I_C

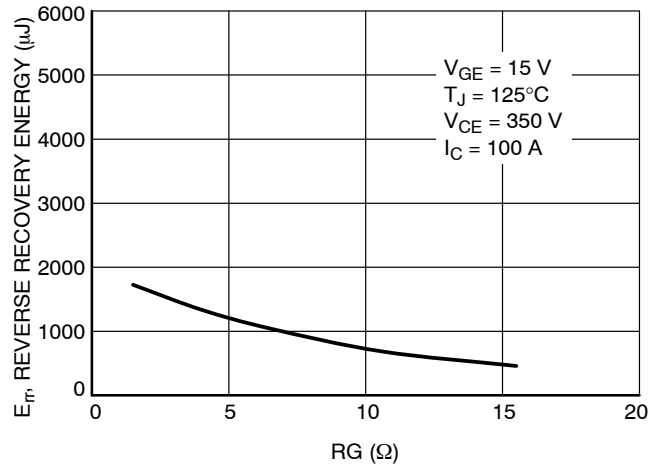


Figure 8. Typical Reverse Recovery Energy Loss vs. R_G

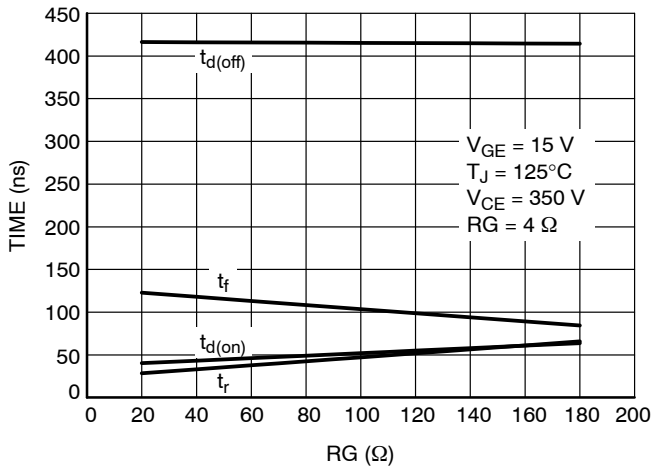


Figure 9. Typical Switching Time vs. I_C

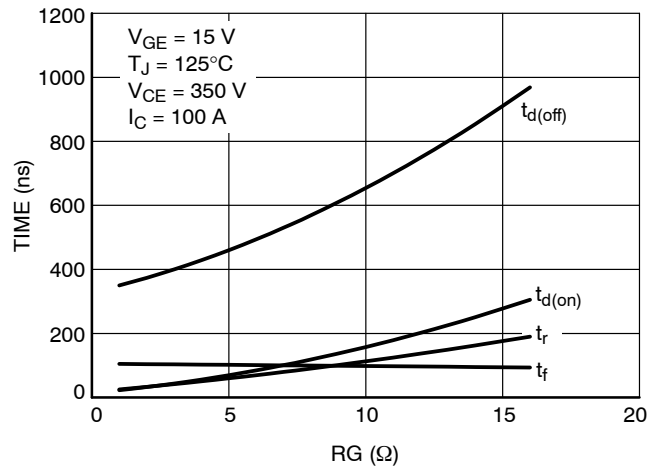


Figure 10. Typical Switching Time vs. R_G

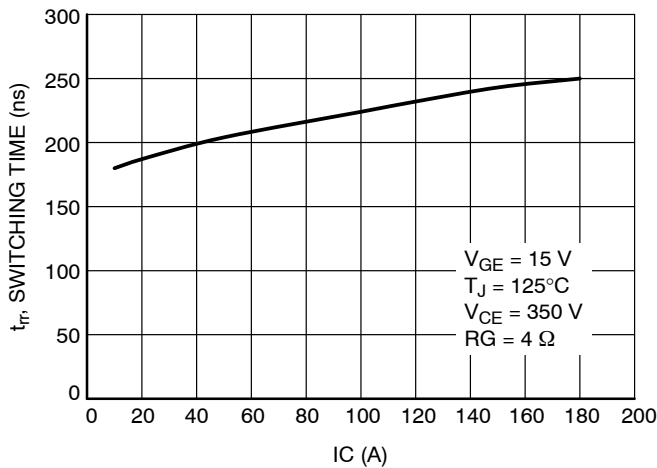


Figure 11. Typical Reverse Recovery Time vs. I_C

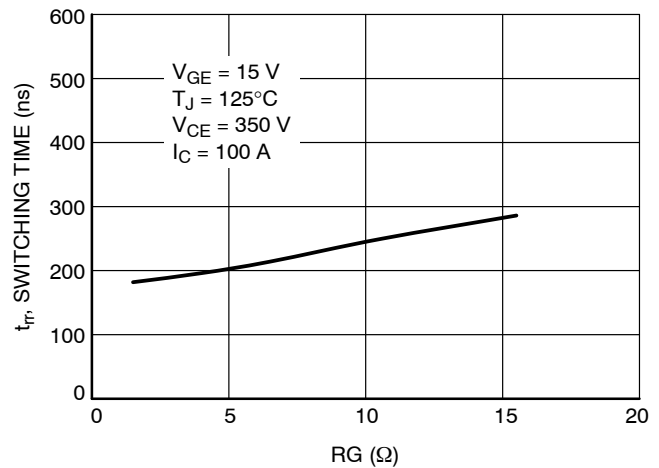


Figure 12. Typical Reverse Recovery Time vs. R_G

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TYPICAL CHARACTERISTICS – HALF BRIDGE IGBT AND NEUTRAL POINT FORWARD DIODE

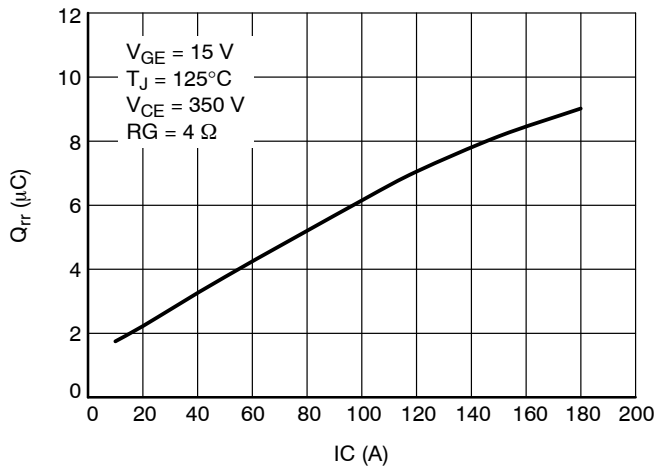


Figure 13. Typical Reverse Recovery Charge vs. I_C

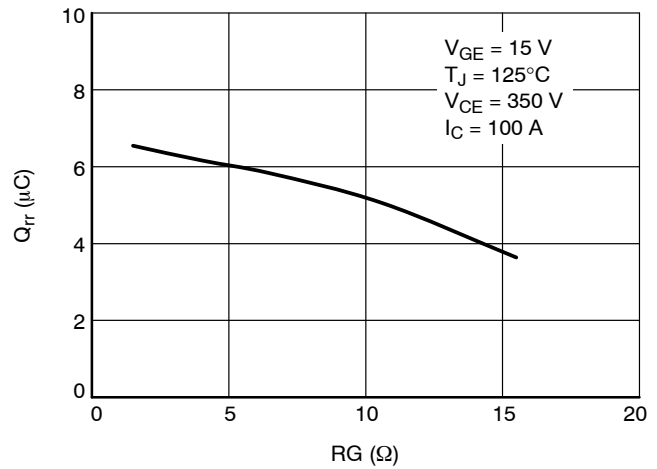


Figure 14. Typical Reverse Recovery Charge vs. R_G

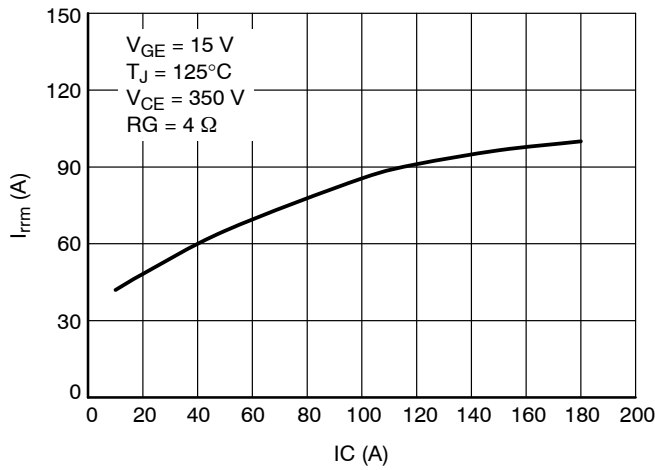


Figure 15. Typical Reverse Recovery Current vs. I_C

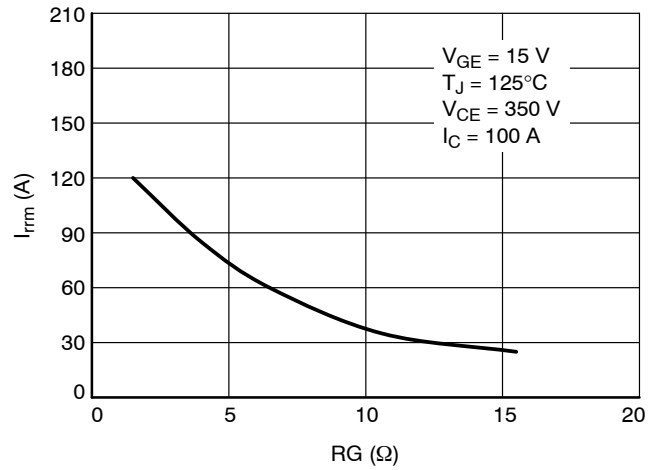


Figure 16. Typical Reverse Recovery Current vs. R_G

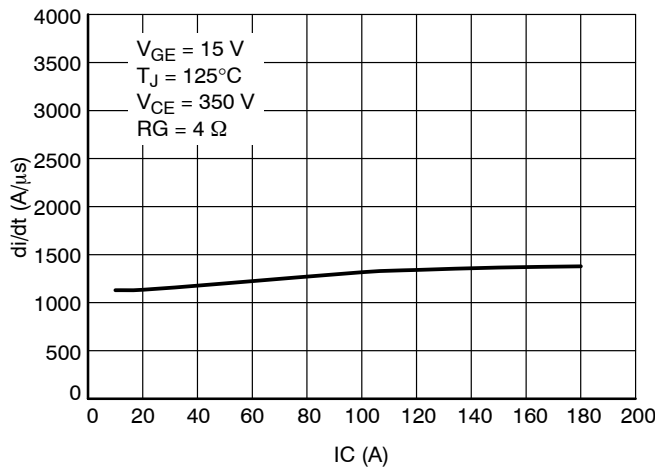


Figure 17. Typical di/dt vs. I_C

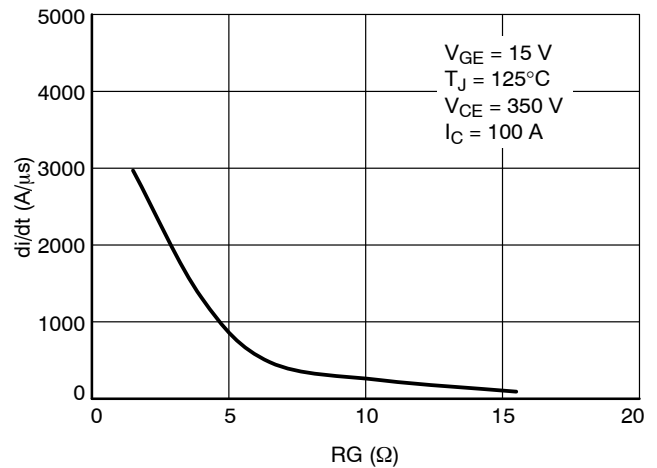


Figure 18. Typical di/dt vs. R_G

TYPICAL CHARACTERISTICS – HALF BRIDGE IGBT AND NEUTRAL POINT FORWARD DIODE

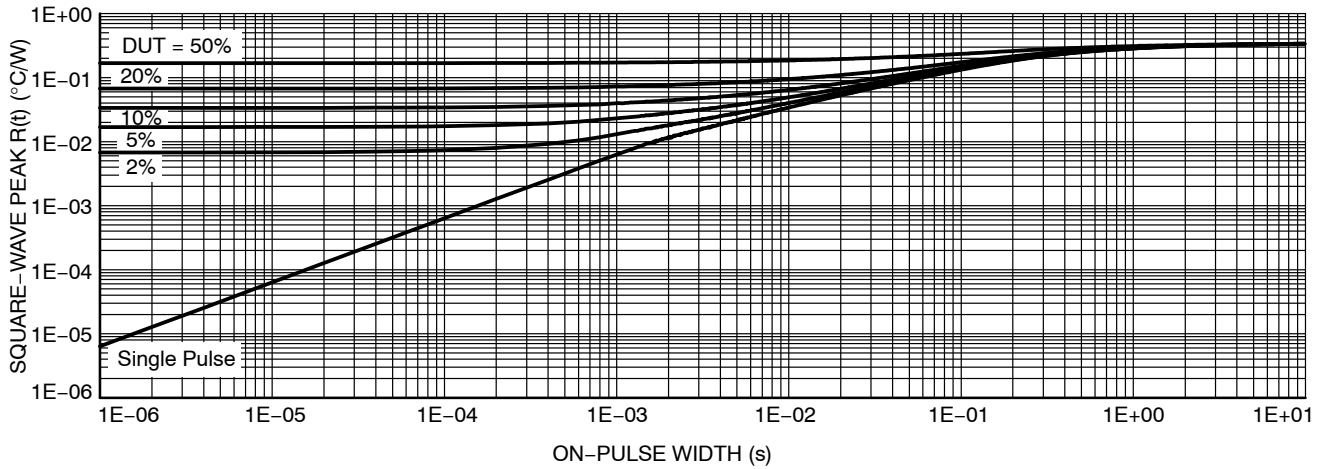


Figure 19. Transient Thermal Impedance (Half Bridge IGBT)

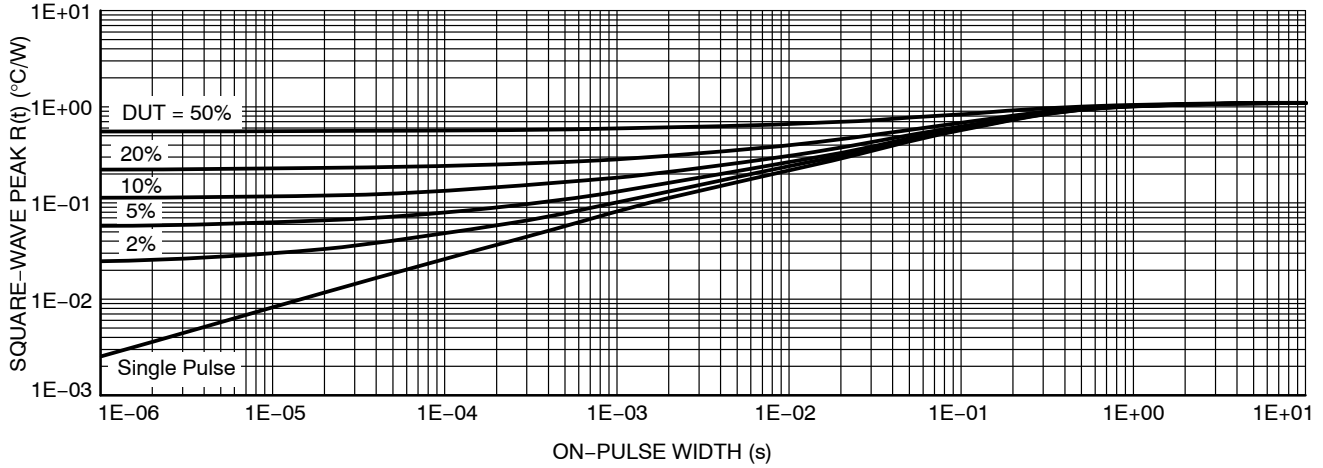


Figure 20. Transient Thermal Impedance (Neutral Point Forward Diode)

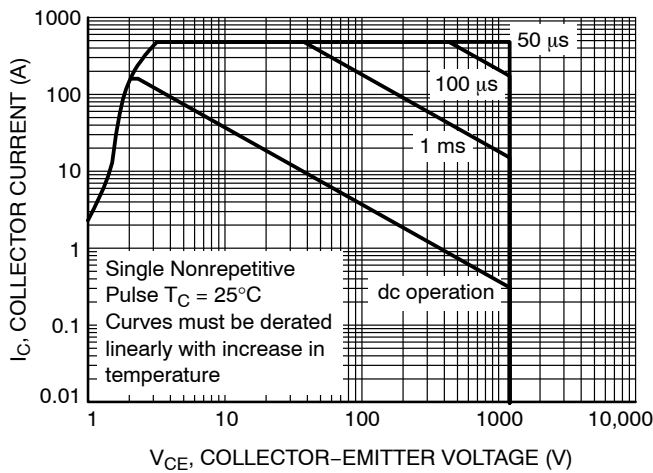


Figure 21. Safe Operating Area

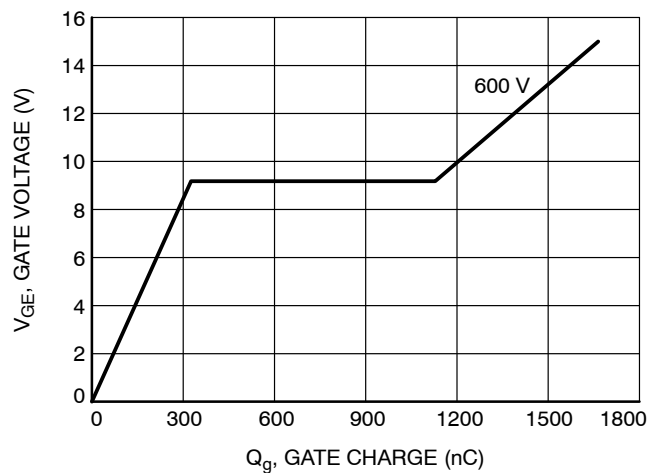


Figure 22. Gate Voltage vs. Gate Charge

TYPICAL CHARACTERISTICS – NEUTRAL POINT IGBT AND HALF BRIDGE FORWARD DIODE

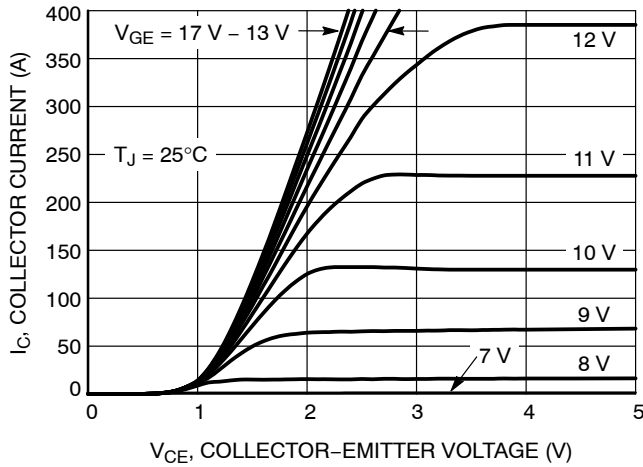


Figure 23. Typical Output Characteristics

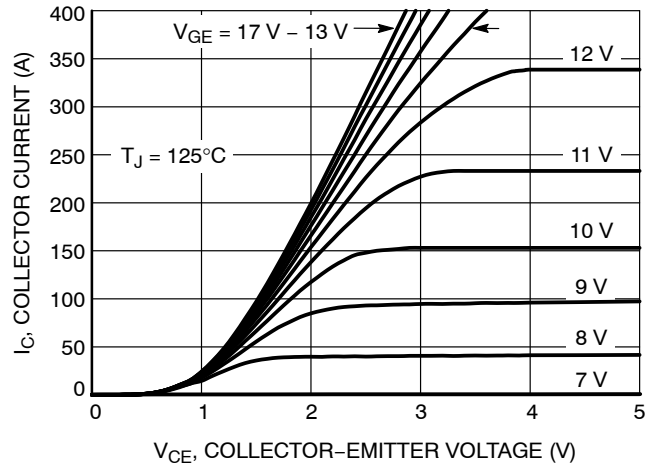


Figure 24. Typical Output Characteristics

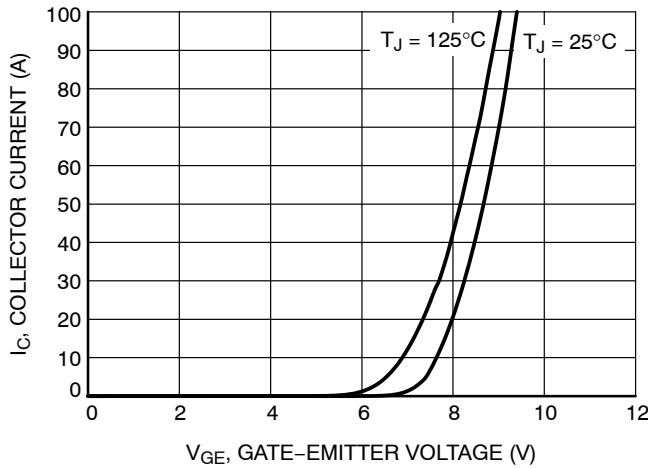


Figure 25. Typical Transfer Characteristics

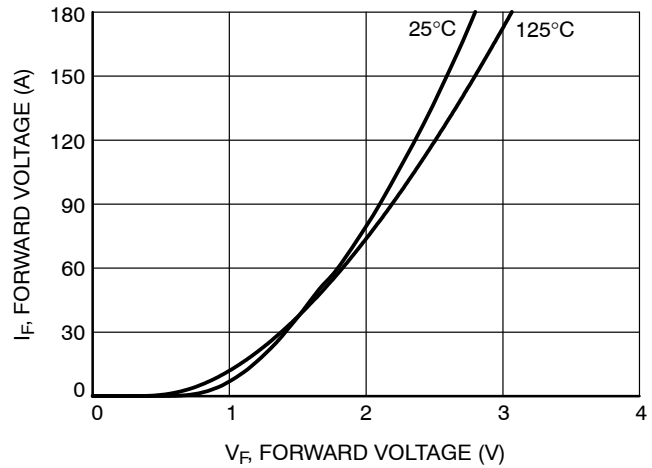


Figure 26. Diode Forward Characteristics

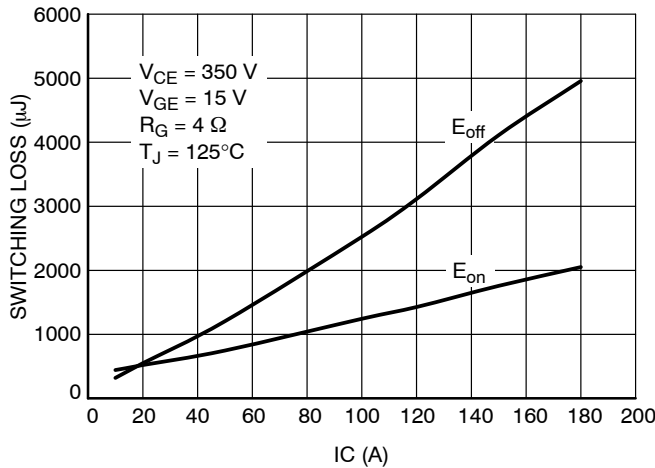


Figure 27. Typical Switching Loss vs. I_C

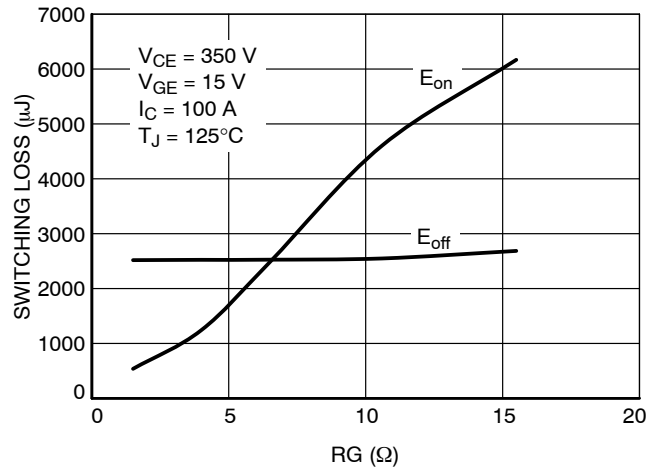


Figure 28. Typical Switching Loss vs. R_G

TYPICAL CHARACTERISTICS – NEUTRAL POINT IGBT AND HALF BRIDGE FORWARD DIODE

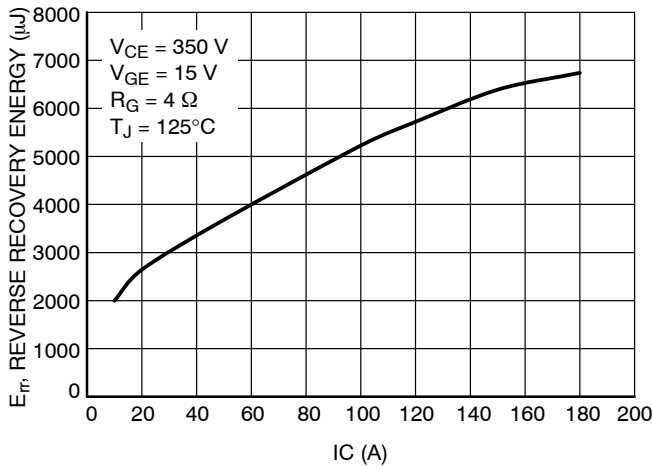


Figure 29. Typical Reverse Recovery Energy Loss vs. I_C

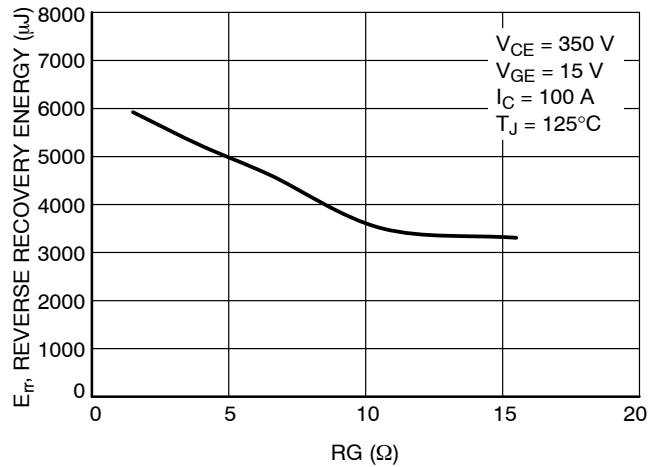


Figure 30. Typical Reverse Recovery Energy Loss vs. R_G

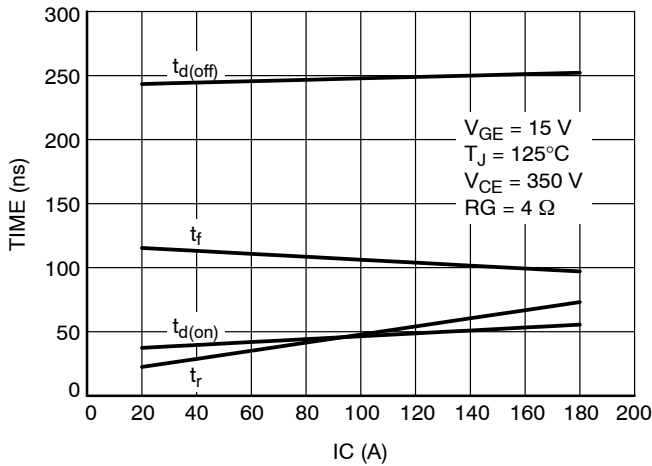


Figure 31. Typical Switching Time vs. I_C

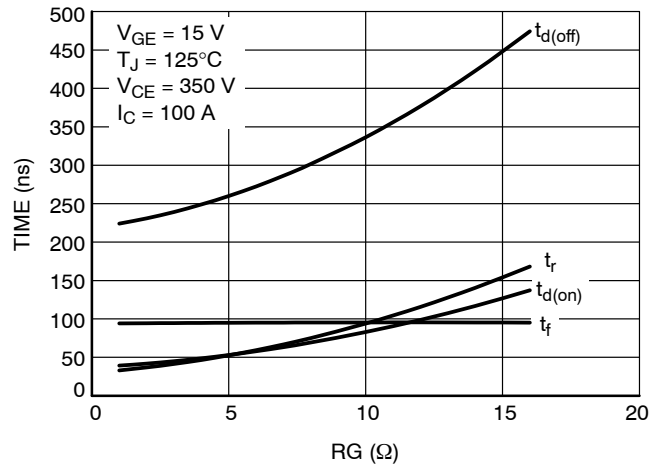


Figure 32. Typical Switching Time vs. R_G

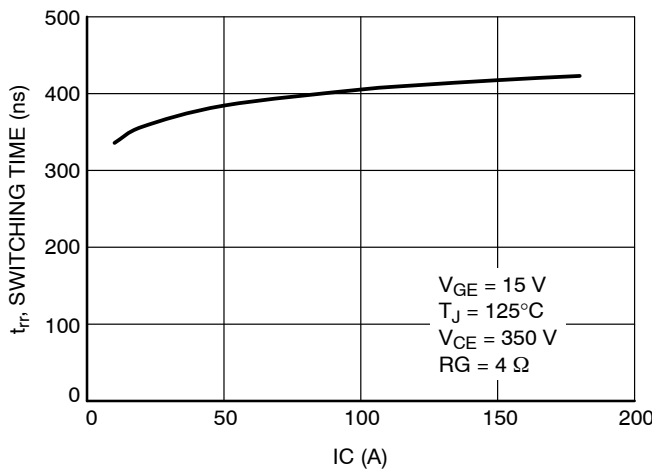


Figure 33. Half Bridge Forward Diode Typical Reverse Recovery Time vs. I_C

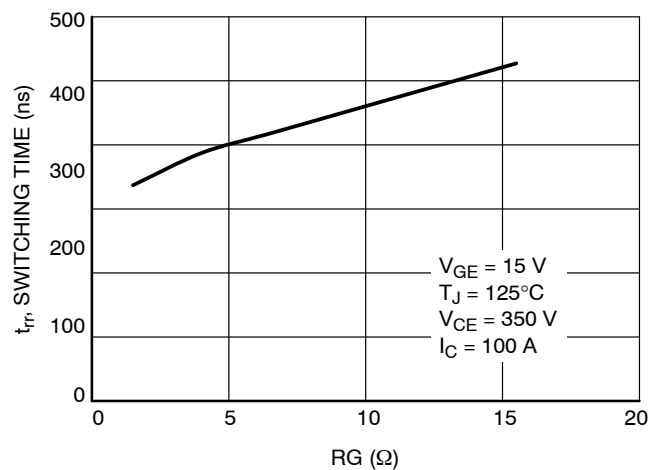


Figure 34. Half Bridge Forward Diode Typical Reverse Recovery Time vs. R_G

TYPICAL CHARACTERISTICS – NEUTRAL POINT IGBT AND HALF BRIDGE FORWARD DIODE

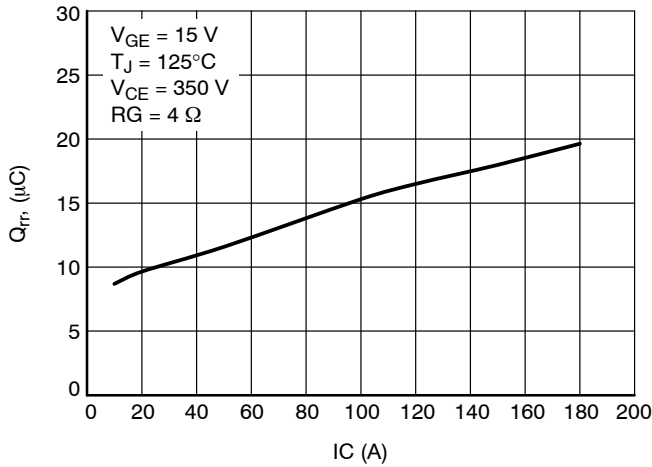


Figure 35. Half Bridge Forward Diode Typical Reverse Recovery Charge vs. I_C

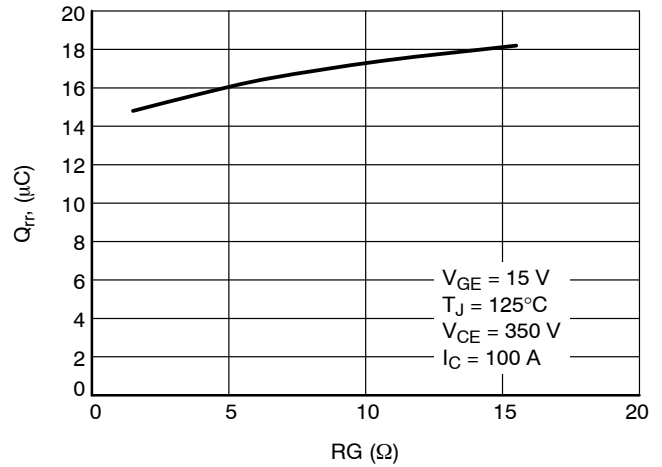


Figure 36. Half Bridge Forward Diode Typical Reverse Recovery Charge vs. R_G

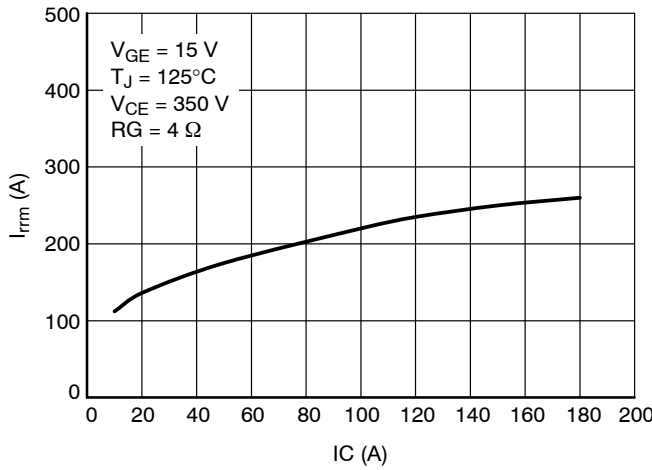


Figure 37. Typical Reverse Recovery Current vs. I_C

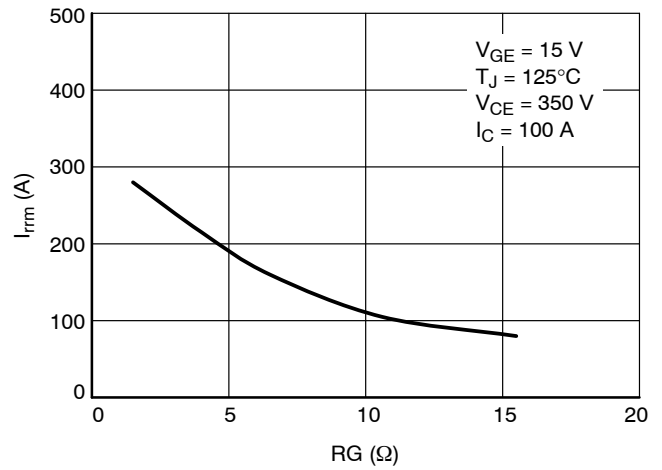


Figure 38. Typical Reverse Recovery Current vs. R_G

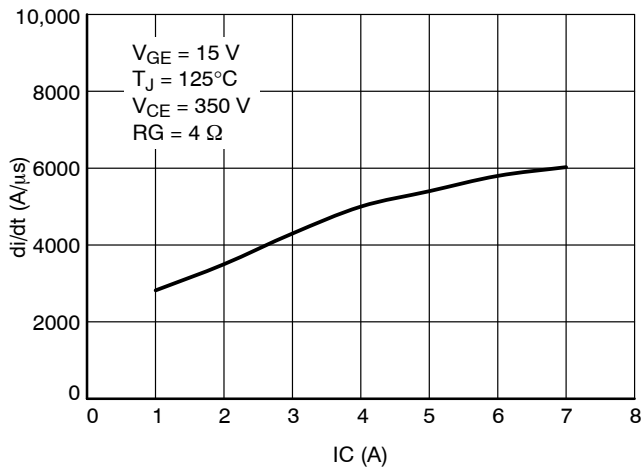


Figure 39. Typical di/dt vs. I_C

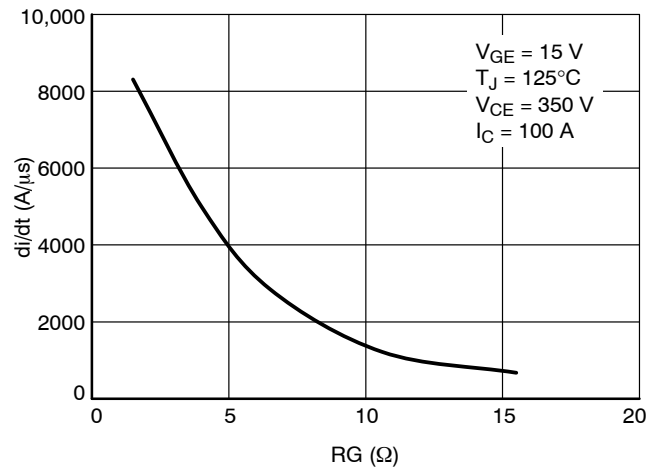


Figure 40. Typical di/dt vs. R_G

NXH160T120L2Q1PG, NXH160T120L2Q1SG

TYPICAL CHARACTERISTICS – NEUTRAL POINT IGBT AND HALF BRIDGE FORWARD DIODE

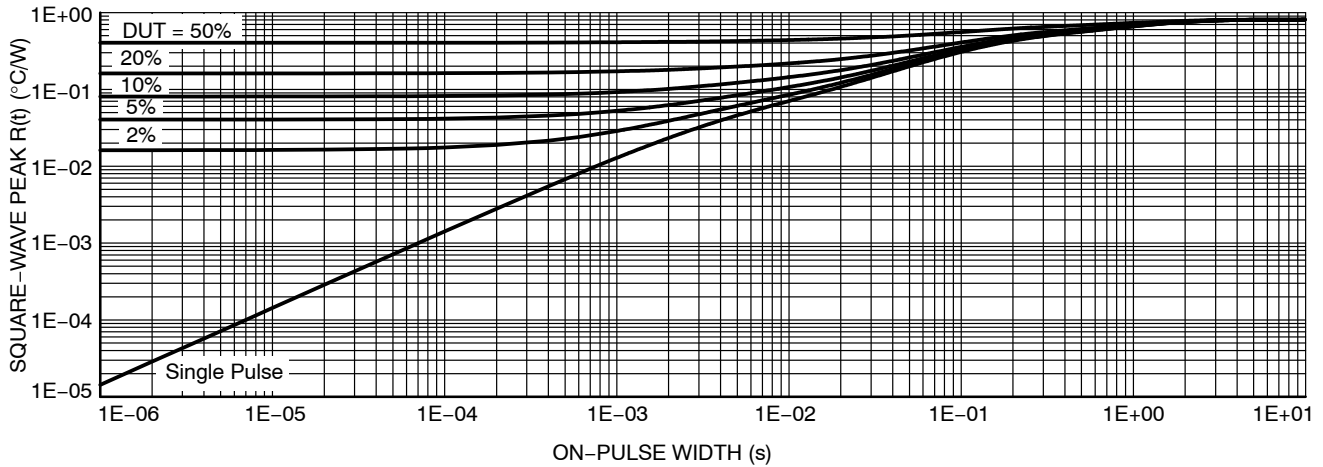


Figure 41. Transient Thermal Impedance (Neutral Point IGBT)

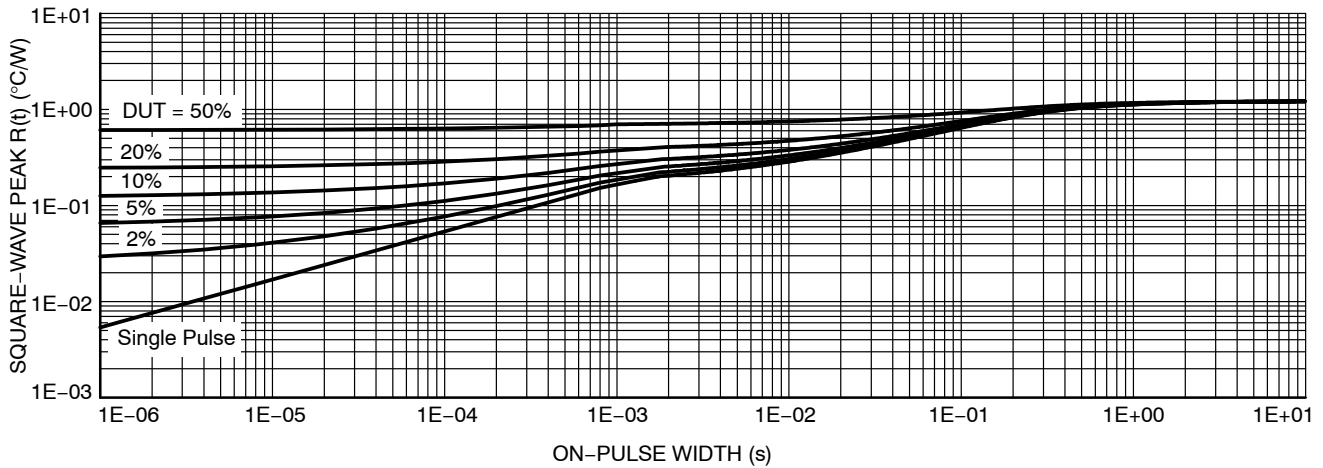


Figure 42. Transient Thermal Impedance (Half Bridge Forward Diode)

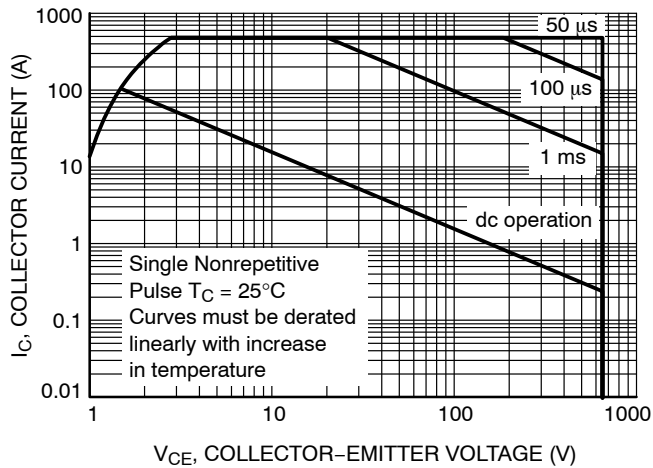


Figure 43. Safe Operating Area

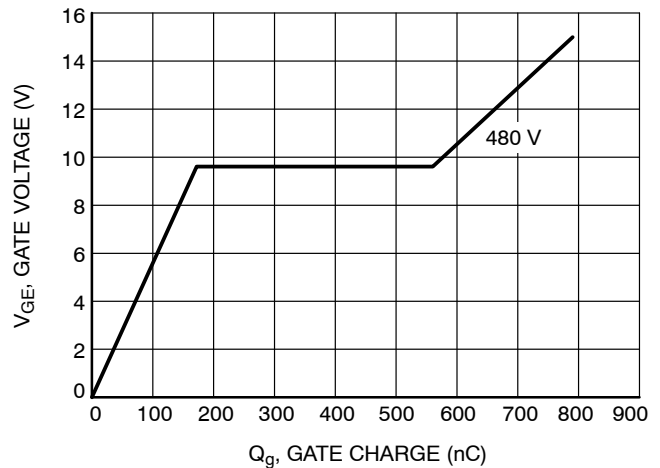


Figure 44. Gate Voltage vs. Gate Charge

TYPICAL CHARACTERISTICS – HALF BRIDGE INVERSE DIODE

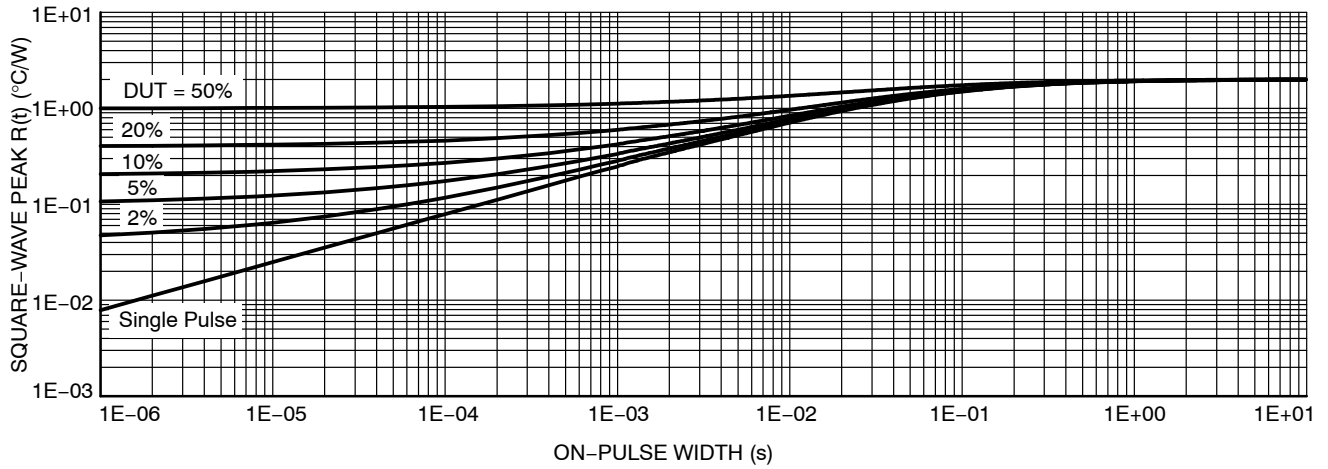


Figure 45. Transient Thermal Impedance

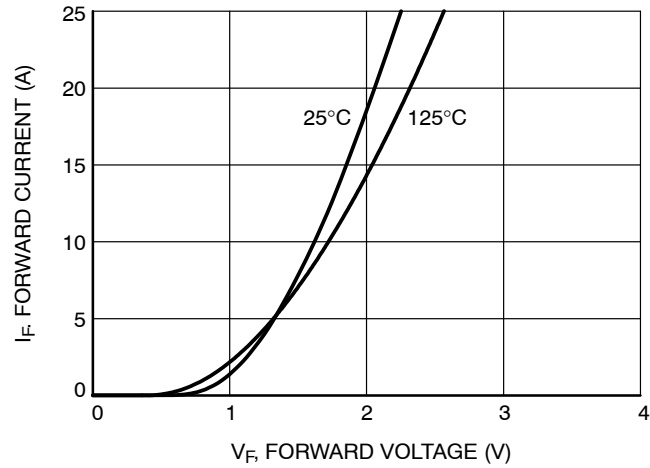


Figure 46. Diode Forward Characteristics

NXH160T120L2Q1PG, NXH160T120L2Q1SG

TYPICAL CHARACTERISTICS – NEUTRAL POINT INVERSE DIODE

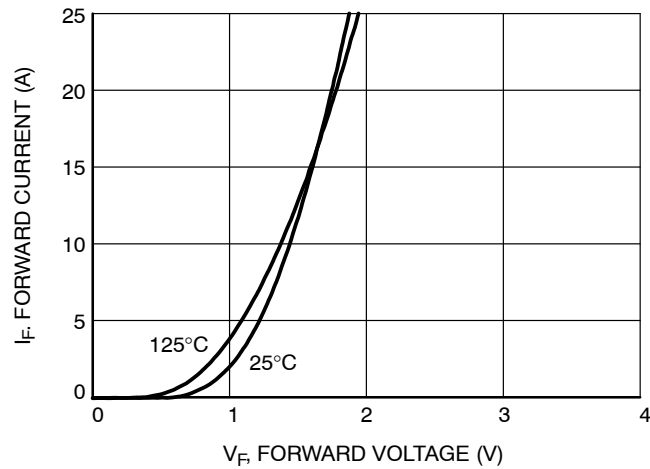


Figure 47. Diode Forward Characteristics

TYPICAL CHARACTERISTICS – THERMISTOR

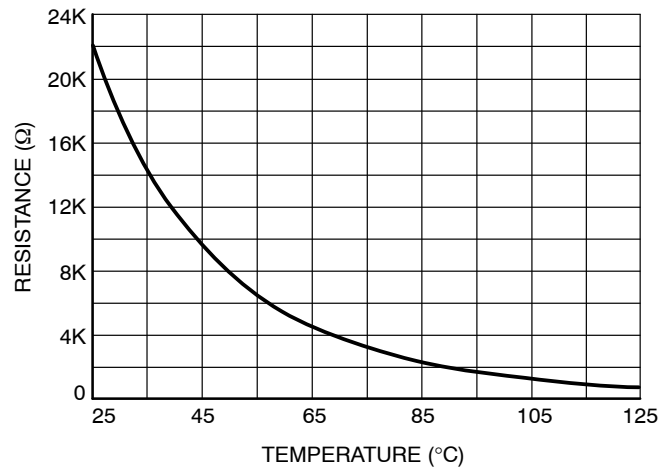


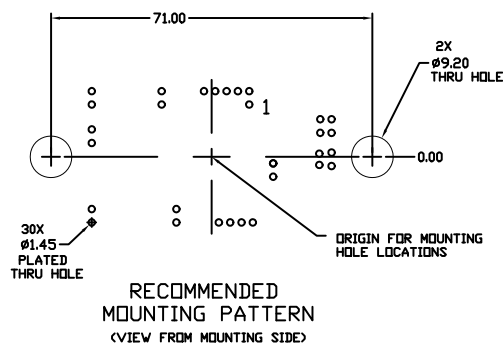
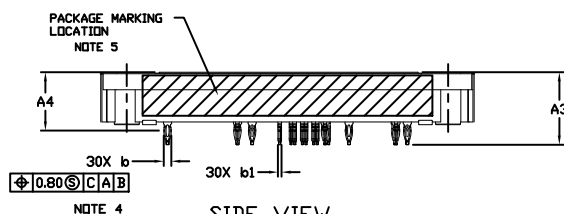
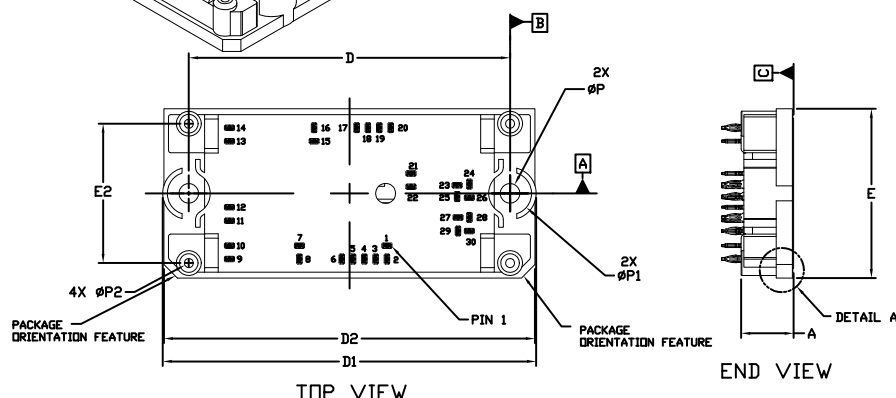
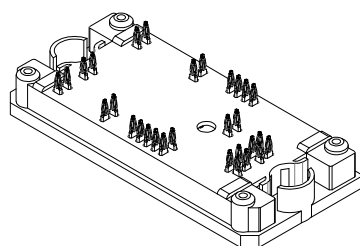
Figure 48. Thermistor Characteristics

ORDERING INFORMATION

Orderable Part Number	Package	Shipping
NXH160T120L2Q1PG (Press Fit)	Q1PACK – Case 180AD (Pb-Free and Halide-Free)	21 Units / Blister Tray
NXH160T120L2Q1SG (Solder Pin)	Q1PACK – Case 180AQ (Pb-Free and Halide-Free)	21 Units / Blister Tray

PIM30, 71x37.4
CASE 180AD
ISSUE E

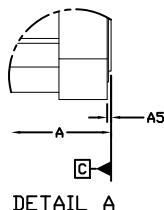
DATE 28 NOV 2017



NOTES

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
2. CONTROLLING DIMENSION: MILLIMETERS
3. DIMENSIONS b AND b1 APPLY TO THE PLATED TERMINALS AND ARE MEASURED AT DIMENSION AA.
4. POSITION OF THE CENTER OF THE TERMINALS IS DETERMINED FROM DATUM B THE CENTER OF DIMENSION D, X DIRECTION, AND FROM DATUM A, Y DIRECTION. POSITIONAL TOLERANCE, AS NOTED IN DRAWING, APPLIES TO EACH TERMINAL IN BOTH DIRECTIONS.
5. PACKAGE MARKING IS LOCATED AS SHOWN ON THE SIDE OPPOSITE THE PACKAGE ORIENTATION FEATURES.

MOUNTING HOLE POSITION			MOUNTING HOLE POSITION		
PIN	X	Y	PIN	X	Y
1	8.30	11.55	16	-7.80	-14.50
2	8.30	14.50	17	1.60	-14.50
3	5.80	14.50	18	4.10	-14.50
4	3.30	14.50	19	6.60	-14.50
5	0.80	14.50	20	9.10	-14.50
6	-1.70	14.50	21	13.60	-4.40
7	-11.05	11.55	22	13.60	-1.45
8	-11.05	14.50	23	23.80	-1.80
9	-26.50	14.50	24	26.50	-2.05
10	-26.50	11.55	25	23.80	0.75
11	-26.50	6.05	26	26.50	0.90
12	-26.50	3.05	27	24.00	5.30
13	-26.50	-11.55	28	26.50	5.30
14	-26.50	-14.50	29	24.00	8.30
15	-7.80	-11.55	30	26.50	8.30



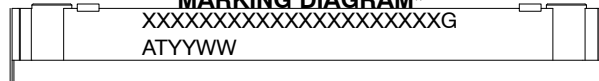
NOTE 4

DIM	MILLIMETERS	
	MIN.	NOM.
A	11.10	12.10
A3	15.50	16.50
A4	12.88	BSC
A5	0.00	0.45
b	1.61	1.71
b1	0.75	0.85
D	70.50	71.50
D1	82.00	83.00
D2	81.50	82.50
E	36.90	37.90
E2	30.30	31.30
P	4.30	4.50
P1	9.30	9.70
P2	1.90	2.10

PIN	PIN POSITION		PIN	PIN POSITION	
	X	Y		X	Y
1	8.30	-11.55	16	-7.800	14.500
2	8.30	-14.50	17	1.60	14.50
3	5.80	-14.50	18	4.10	14.50
4	3.30	-14.50	19	6.60	14.50
5	0.80	-14.50	20	9.10	14.50
6	-1.70	-14.50	21	13.60	4.40
7	-11.05	-11.55	22	13.60	1.45
8	-11.05	-14.50	23	23.80	1.80
9	-26.50	-14.50	24	26.50	2.05
10	-26.50	-11.55	25	23.80	-0.70
11	-26.50	-6.05	26	26.50	-0.95
12	-26.50	-3.05	27	24.00	-5.30
13	-26.50	11.55	28	26.50	-5.30
14	-26.50	14.50	29	24.00	-8.30
15	-7.80	11.55	30	26.50	-8.30

GENERIC

MARKING DIAGRAM*



XXXXX = Specific Device Code

G = Pb-Free Package

AT = Assembly & Test Site Code

YYWW = Year and Work Week Code

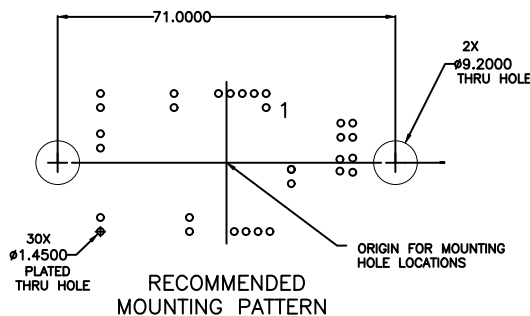
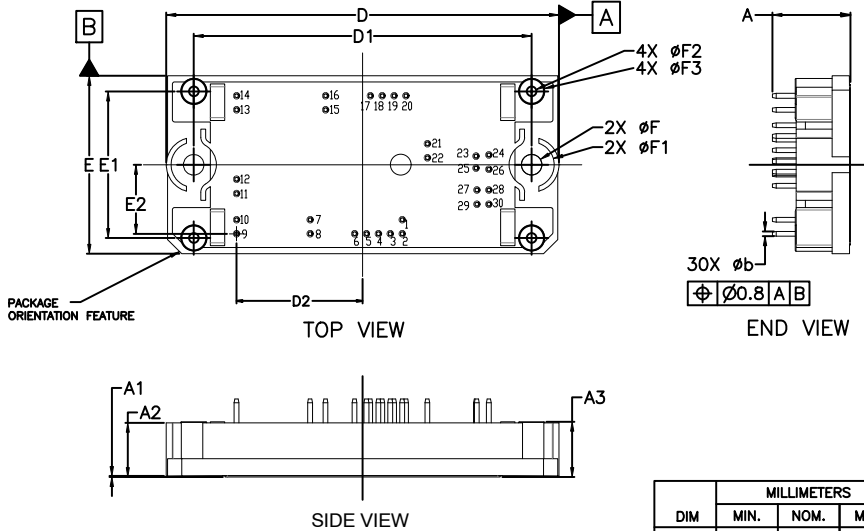
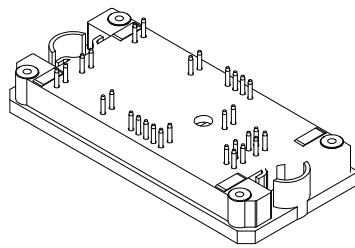
*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "▪", may or may not be present. Some products may not follow the Generic Marking.

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PIM30, 71x37.4
CASE 180AQ
ISSUE A

DATE 25 JUN 2018



NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
2. CONTROLLING DIMENSION: MILLIMETERS
3. DIMENSIONS b AND b1 APPLY TO THE PLATED TERMINALS AND ARE MEASURED AT DIMENSION A4.
4. POSITION OF THE CENTER OF THE TERMINALS IS DETERMINED FROM DATUM B THE CENTER OF DIMENSION D, X DIRECTION, AND FROM DATUM A, Y DIRECTION. POSITIONAL TOLERANCE, AS NOTED IN DRAWING, APPLIES TO EACH TERMINAL IN BOTH DIRECTIONS.
5. PACKAGE MARKING IS LOCATED AS SHOWN ON THE SIDE OPPOSITE THE PACKAGE ORIENTATION FEATURES.

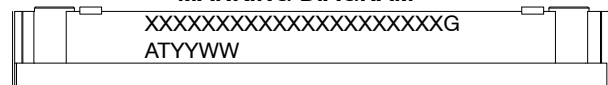
MOUNTING HOLE POSITION			MOUNTING HOLE POSITION		
PIN	X	Y	PIN	X	Y
1	8.30	11.55	16	-7.800	-14.50
2	8.30	14.50	17	1.60	-14.50
3	5.80	14.50	18	4.10	-14.50
4	3.30	14.50	19	6.60	-14.50
5	0.80	14.50	20	9.10	-14.50
6	-1.70	14.50	21	13.60	-4.40
7	-11.05	11.55	22	13.60	-1.45
8	-11.05	14.50	23	23.80	-1.80
9	-26.50	14.50	24	26.50	-2.05
10	-26.50	11.55	25	23.80	0.70
11	-26.50	6.05	26	26.50	0.95
12	-26.50	3.05	27	24.00	5.30
13	-26.50	-11.55	28	26.50	5.30
14	-26.50	-14.50	29	24.00	8.30
15	-7.80	-11.55	30	26.50	8.30

NOTE 4

DIM	MILLIMETERS		
	MIN.	NOM.	MAX.
A	15.90	16.40	16.90
A1	---	0.30	0.60
A2	10.90	11.40	11.90
A3	11.10	11.60	12.10
b	0.90	1.00	1.10
D	82.00	82.50	83.00
D1	70.50	71.00	71.50
D2	26.50 REF		
E	36.90	37.40	37.90
E1	30.30	30.80	31.30
E2	14.50 REF		
F	4.30	4.30	4.50
F1	9.5 REF		
F2	2.0 REF		
F3	5.5 REF		

PIN	PIN POSITION		PIN	PIN POSITION	
	X	Y		X	Y
1	8.30	-11.55	16	-7.800	14.50
2	8.30	-14.50	17	1.60	14.50
3	5.80	-14.50	18	4.10	14.50
4	3.30	-14.50	19	6.60	14.50
5	0.80	-14.50	20	9.10	14.50
6	-1.70	-14.50	21	13.60	4.40
7	-11.05	-11.55	22	13.60	1.45
8	-11.05	-14.50	23	23.80	1.80
9	-26.50	-14.50	24	26.50	2.05
10	-26.50	-11.55	25	23.80	-0.70
11	-26.50	-6.05	26	26.50	-0.95
12	-26.50	-3.05	27	24.00	-5.30
13	-26.50	11.55	28	26.50	-5.30
14	-26.50	14.50	29	24.00	-8.30
15	-7.80	11.55	30	26.50	-8.30

GENERIC
MARKING DIAGRAM*



XXXXX = Specific Device Code
G = Pb-Free Package
AT = Assembly & Test Site Code
YYWW = Year and Work Week Code

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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